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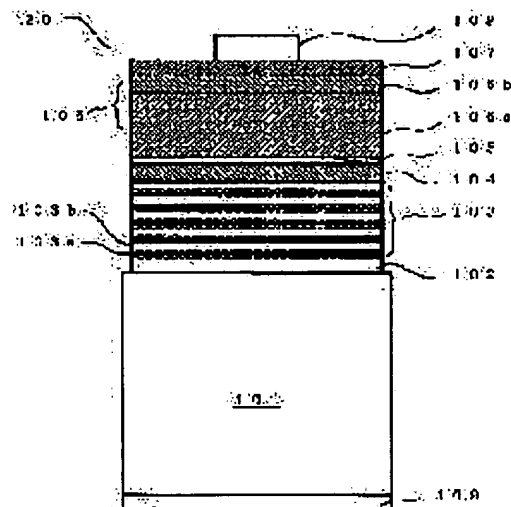
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## (54) AlGaInP LIGHT EMITTING ELEMENT WITH WINDOW LAYER

### (57)Abstract:

**PROBLEM TO BE SOLVED:** To acquire an AlGaInP light emitting element of high brightness by providing a specified p-type clad layer, a light emitting layer and an n-type clad layer in a GaAs single crystalline substrate and providing a window layer consisting of zinc oxide thereon.

**SOLUTION:** P-type clad layers 104, 106 consisting of  $(Al_xGa_{1-x})_{1-x}In_xP$  ( $0 \leq x \leq 1$ ,  $0 < x < 1$ ), a light emitting layer 105, an n-type clad layer and a window layer 107 of a polycrystalline zinc oxide are formed on a GaAs single crystalline substrate 101. In the process, the composition ratio  $(1-X)$  of indium of an AlGaInP layer is made 0.5, thereby obtaining good lattice-match to a GaAs substrate 101. It is desirable that zinc oxide is hexagonal wurtzite type crystal, a polycrystalline zinc oxide film is preferably orientated C-axially and the resistivity is made  $1 \times 10^3 \Omega \cdot cm$  or less. Although zinc oxide crystal shows n-type conduction in its so-called undoped state wherein impurities are not added intentionally, an n-type zinc oxide window layer 107 of lower resistivity can be formed by doping a group III element.



## LEGAL STATUS

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